

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 0050-1659-2 PCT		SERIAL NO. 09/530,599	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hironobu MIZUNO, et al.			
				FILING DATE May 9, 2000		GROUP 2655	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
R/S	AA	5,637,372	06/10/97	Junji TOMINAGA, et al.			
	AB	5,789,055	08/04/98	Doo Won YOON			
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
R/S	AO	5-174422	07/13/93	JAPAN (with English Abstract)			X
	AP	10-112028	04/28/98	JAPAN			X
	AQ	1-303643	12/07/89	JAPAN			X
	AR	9-282661	10/31/97	JAPAN			X
	AS	0 717 404	06/19/96	EUROPE			
AT							
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AY						
	AZ						
Examiner Muhammad Edun Primary Examiner				Date Considered 12/3/99			

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Michikazu HORIE, et al.			
FILING DATE May 9, 2000				GROUP 2185 <i>2655</i>			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>AG</i>	AA	6,143,468	11/07/00	OHNO et al.			
<i>AG</i>	AB	6,004,646	12/21/99	OHNO et al.			
<i>AG</i>	AC	6,294,310	09/25/01	OHNO et al.			
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	AO						
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Examiner Muhammad Edun <i>Primary Examiner</i>				<input type="checkbox"/> Additional References sheet(s) attached Date Considered <i>12/2/04</i>			
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LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Status or Patentee</u>
0050-1449-0	6,143,468	11/07/00	OHNO et al.
<i>2</i> 0050-1500-0	6,004,646	12/21/99	OHNO et al.
<i>2</i> 0050-1656-0 DIV	6,294,310	09/25/01	OHNO et al.
<i>2</i> 0050-1659-2PCT*	09/530,599	05/09/00	PENDING
<i>2</i> 210159US0 CONT	09/919,846	08/02/01	PENDING
<i>2</i> 218899US0	10/059,193	01/31/02	PENDING
<i>2</i> 230271US2 CONT	10/287,582	11/05/02	PENDING

Muhammad Edun
Primary Examiner

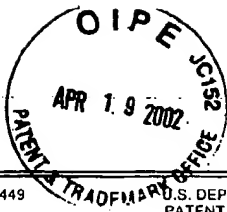
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*Present Application; listed for information

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SHEET 1 OF 1

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hironobu MIZUNO, et al.			
				FILING DATE May 9, 2000		GROUP 2655 2752	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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Examiner		Muhammad Edun			Date Considered 12/3/04		
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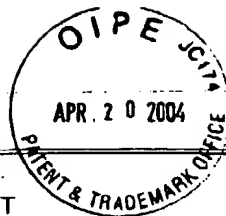
LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent No.</u>	<u>Filing or Issue Date</u>	<u>Status or Patentee</u>
<i>al</i> 0050-1659-2 PCT*	09/530,599	05/09/00	PENDING
<i>al</i> 206527US2 CONT	09/842,035	04/26/01	PENDING

Muhammad Edun
Primary Examiner

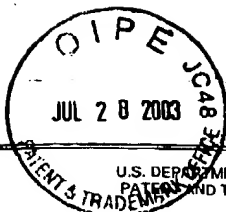
12/3/04

*Present application; listed for information.
GJM/sdj



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET, NO. 0050-1659-2PCT		SERIAL NO. 09/530,599	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hironobu MIZUNO, et al.			
				FILING DATE May 9, 2000		GROUP 2186 2655	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	0 847 049	06/10/1998	EUROPE			
	AP	0 844 607	05/27/1998	EUROPE			
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	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	N. MIYAGAWA, et al., Japanese Journal of Applied Physics, vol. 35, Part I, no. 1B, XP-000729856, pages 502-503, "PHASE CHANGE OPTICAL DISK USING LAND AND GROOVE METHOD APPLICABLE TO PROPOSED SUPER DENSITY REWRITABLE DISC SPECIFICATIONS", 1996					
	AX						
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	AZ						
Examiner Muhammad Edun Primary Examiner					<input type="checkbox"/> Additional References sheet(s) attached Date Considered 12/3/04		
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SHEET 1 OF 1

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PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

0050-1659-2PCT

SERIAL NO.

09/530,599

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hironobu MIZUNO, et al.

FILING DATE

May 9, 2000

GROUP

2186

2655

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>AE</i>	AA	6,411,585	06/25/2002	S. KOBAYASHI			
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FOREIGN PATENT DOCUMENTS

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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Muhammad Edun

Primary Examiner

Date Considered

12/3/04

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LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Inventor/ Applicant</u>
00050-1659-2 PCT*	09/530,599	05/09/00	MIZUNO, et al.
254584US0 CONT	10/900,108	07/28/04	MIZUNO, et al.

Muhammad Edun
Primary Examiner

12/3/04

*Present Application; listed for information
NFO/amr/wal



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OCT 12 2004

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LIST OF RELATED CASES

<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Inventor/ Applicant</u>
<i>al</i> 0050-1659-2 PCT*	09/530,599	05/09/00	MIZUNO et al.
<i>al</i> 255679US2 CONT	10/890,414	07/14/04	OHNO et al.

Muhammad Edun,
Primary Examiner

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*Present Application; listed for information

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